Search Notes

Application/Control	No. Applican Reexami	t(s)/Patent under nation
09/886,191	CRADDO	OCK ET AL.
Examiner	Art Unit	
Tanh Q. Nguyen	2182	

SEARCHED					
Class	Subclass	Date .	Examiner		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
e-DAN Seach inventor seach, Fort Seach Results attached Consult S/N 09/886,193 09/861,952	03/07/05	TQN		
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